

SIGC42T120CL

IGBT Chip in NPT-technology

FEATURES:

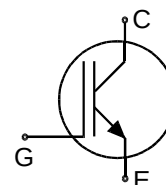
- 1200V NPT technology 180µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

This chip is used for:

- power module
BSM25GD120DLC E3224

Applications:

- drives



Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC42T120CL	1200V	25A	6.59 x 6.49 mm ²	sawn on foil	C67078-A4675-A001
SIGC42T120CL	1200V	25A	6.59 x 6.49 mm ²	unsawn	C67078-A4675-A002

MECHANICAL PARAMETER:

Raster size	6.59 x 6.49	mm ²
Emitter pad size	2 x (2.18 x 1.58)	
Gate pad size	1.06 x 0.65	
Area total / active	42.8 / 33.5	
Thickness	180	µm
Wafer size	150	mm
Flat position	90	grd
Max.possible chips per wafer	334 pcs	
Passivation frontside	Photoimide	
Emitter metallization	3200 nm Al Si 1%	
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding	
Die bond	electrically conductive glue or solder	
Wire bond	Al, <500µm	
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm	
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month	

MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V_{CE}	1200	V
DC collector current, limited by T_{jmax}	I_C	25	A
Pulsed collector current, t_p limited by T_{jmax}	I_{Cpuls}	50	A
Gate emitter voltage	V_{GE}	± 20	V
Operating junction and storage temperature	T_j, T_{stg}	-55 ... +150	°C

STATIC CHARACTERISTICS (tested on chip), $T_j=25^\circ\text{C}$, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-emitter breakdown voltage	$V_{(BR)CES}$	$V_{GE}=0V, I_C=1.5mA$	1200			V
Collector-emitter saturation voltage	$V_{CE(sat)}$	$V_{GE}=15V, I_C=25A$	1.8	2.2	2.6	
Gate-emitter threshold voltage	$V_{GE(th)}$	$I_C=1mA, V_{GE}=V_{CE}$	4.5	5.5	6.5	
Zero gate voltage collector current	I_{CES}	$V_{CE}=1200V, V_{GE}=0V$			150	μA
Gate-emitter leakage current	I_{GES}	$V_{CE}=0V, V_{GE}=30V$			120	nA

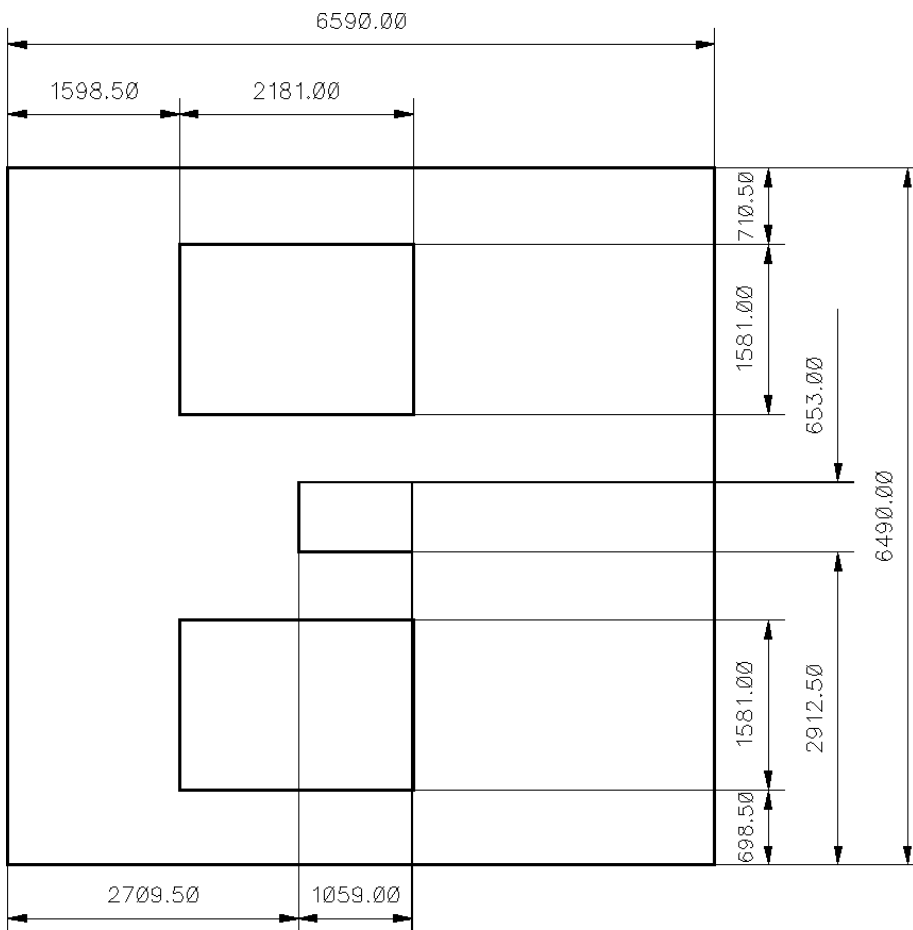
ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Input capacitance	C_{iss}	$V_{CE}=25V,$ $V_{GE}=0V,$ $f=1MHz$	-	1.65	-	nF
Output capacitance	C_{oss}		-	-	-	
Reverse transfer capacitance	C_{rss}		-	0.11	-	

SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	$T_j=125^\circ\text{C}$ $V_{CC}=600V,$ $I_C=25A,$ $V_{GE}=\pm 15V,$ $R_G=33\Omega$	-	70	-	ns
Rise time	t_r		-	50	-	
Turn-off delay time	$t_{d(off)}$		-	320	-	
Fall time	t_f		-	60	-	

CHIP DRAWING:



1 mm

all measurements in um



Preliminary

SIGC42T120CL

FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	BSM25GD120DLC E3224	Package Econo 2 short pin
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DESCRIPTION:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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